Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/762,170	LEE ET AL.	
Examiner	Art Unit	
Duc T. Doan	2188	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
(711/167;711/135;710/57;711/137)	2/15/2006	DD	
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